

<u>Help</u>

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	n of the following is true for an RF plasma assuming that the top electrode is connected to the and the bottom electrode is connected to the RF source?
	he current passing through the ion sheath is proportional to the square of the thickness of the ion heath
O D	Due to the loss of electrons to the walls, the bulk of the plasma becomes slightly negative
	© All Rights  fter accumulation of electrons on the lower electrode, the remaining electrons in the plasma are  ushed away and an ion sheath is formed near the electrode  hnique fédérale de Lausanne. All rights reserved except where noted. edX, Open edX and their respective logos are
	marks of edX Inc. विदेशिकारकश्चिम <mark>होतिसहिश्कीर्यांत्र</mark> िकारांकां, electrons tend to charge the top electrode
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wafer is	can be done in RF plasma etching for enhancing the etching rate on the RF electrode side where the placed?
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